

## Using the **ADL5562** Differential Amplifier to Drive Wide Bandwidth ADCs for High IF AC-Coupled Applications

### CIRCUIT FUNCTION AND BENEFITS

This circuit provides high performance, high frequency sampling using the **ADL5562**, a high performance, differential, low noise, ultralow distortion, high output linearity, pin-strappable gain amplifier, and high speed ADCs. The **ADL5562** is optimized for driving high frequency IF sampling ADCs. When coupled with a high speed ADC like the **AD9445**, **AD9246**, or **AD6655**, it provides exceptional SFDR performance beyond 100 MSPS at its maximum gain.

### CIRCUIT DESCRIPTION

**Table 1. Devices Connected/Referenced**

Product	Description
<b>ADL5562</b>	3.3 GHz ultralow distortion RF/IF differential amplifier
<b>AD9445</b>	14-bit, 105 MSPS/125 MSPS analog-to-digital converter

This circuit employs the **ADL5562** high output linearity amplifier to provide variable gain, isolation, and source matching to a high speed ADC like the **AD9445**. Using this circuit with the **ADL5562** in a gain of 6 dB (minimum gain), an SFDR performance of 84 dBc is achieved with an input signal of 140 MHz sampled at 125 MSPS, as indicated in Figure 2.

The **ADL5562** should be driven differentially (for optimal performance) by a wideband 1:1 transmission line balun (or impedance transformer) followed by two 34.8 Ω resistors in parallel with the input impedance of the **ADL5562**. This provides a wideband match to a 50 Ω source as depicted in

Figure 1. Note that the **ADL5562** has different input impedances for each gain setting (400 Ω, 200 Ω, and 133 Ω for gain settings of 6 dB, 12 dB, and 15.5 dB, respectively). The 34.8 Ω resistors provide an optimum match for a gain of 12 dB, but the match is good enough to use the same values for a gain of 6 dB or 15.5 dB. Figure 1 shows the **ADL5562** connected for a gain of 6 dB. The outputs of the **ADL5562** are ac-coupled to avoid common-mode dc loading and to allow the amplifier to be biased to an internally generated mid-supply level. The 33 Ω series resistors help to improve the isolation between the **ADL5562** and any switching currents present at the analog-to-digital sample-and-hold input circuitry.

There are several configuration options available to the designer when using the **ADL5562**. Figure 1 shows a simplified wideband interface with the **ADL5562** driving an **AD9445**. The **AD9445** is a 14-bit, 105 MSPS/125 MSPS analog-to-digital converter with a buffered wideband input, which presents a 2 kΩ||3 pF differential load impedance and requires a 2 V p-p differential input swing to reach full scale. This circuit provides variable gain, isolation, and source matching for the **AD9445**. Using this circuit with the **ADL5562** in a gain of 6 dB, the wideband system response of Figure 3 is obtained, which has a 3 dB bandwidth of approximately 700 MHz. The wideband frequency response is an advantage in broadband applications such as predistortion receiver designs and instrumentation applications. However, by designing for a wide analog input frequency range, the cascaded SNR performance is somewhat degraded due to high frequency noise aliasing into the first Nyquist zone.

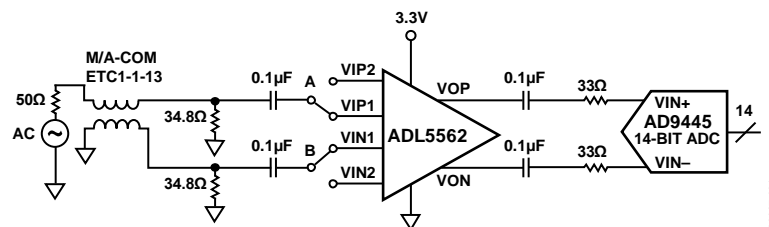


Figure 1. Wideband ADC Interfacing Example Featuring the **ADL5562** and the **AD9445**  
(Simplified Schematic; Decoupling and All Connections Not Shown)

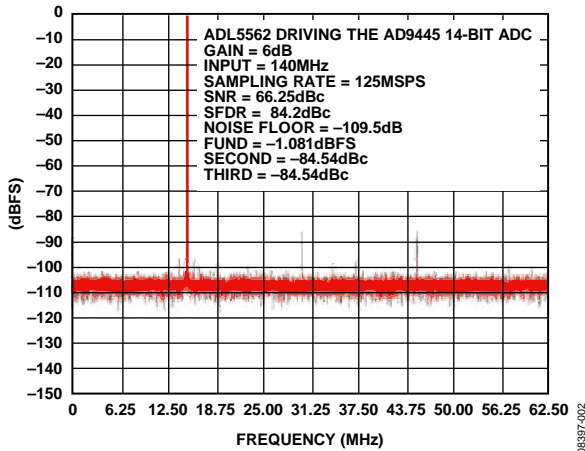


Figure 2. Measured Single-Tone Performance of the Circuit in Figure 1 for a 140 MHz Input Signal Sampled at 125 MSPS

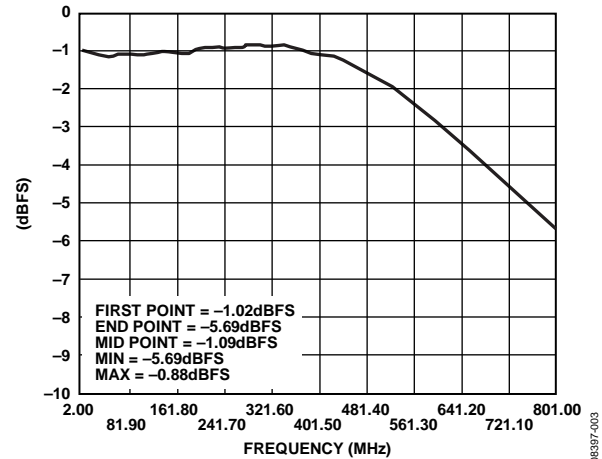


Figure 3. Measured Frequency Response of Wideband Circuit in Figure 1

**COMMON VARIATIONS**

An alternative narrow-band approach is presented in Figure 4. By designing a narrow band-pass antialiasing filter between the ADL5562 and the target ADC, the output noise of the ADL5562 outside of the intended Nyquist zone can be attenuated, helping to preserve the available SNR of the ADC.

In general, the SNR improves several dB when including a reasonable order antialiasing filter. In this example, a low loss 1:1 (impedance ratio) input transformer is used to match the ADL5562’s balanced input to a 50 Ω unbalanced source, resulting in minimum insertion loss at the input.

The narrow-band circuit shown in Figure 4 is optimized for driving some of Analog Devices popular unbuffered input ADCs, such as the AD9246, AD9640, and AD6655.

Table 2 includes antialiasing filter component recommendations for popular IF sampling center frequencies. Inductor L5 works in parallel with the on-chip ADC input capacitance and a portion of the capacitance presented by C4 to form a resonant tank circuit. The resonant tank helps to ensure the ADC input looks like a real resistance at the target center frequency. Additionally, the L5 inductor shorts the ADC inputs at dc, which introduces a

zero into the transfer function. The 1 nF ac coupling capacitors introduce additional zeros into the transfer function. The final overall frequency response takes on a band-pass characteristic, helping to reject noise outside of the intended Nyquist zone. Table 2 provides initial suggestions for prototyping purposes. Some empirical optimization may be needed to help compensate for actual PCB parasitics. Details of designing the interstage filters can be found in application notes AN-827, *A Resonant Approach to Interfacing Amplifiers to Switched Capacitor ADCs*, and AN-742, *Frequency Domain Response of Switched Capacitor ADCs*.

The circuit in Figure 1 requires 1% resistors for the two 34.8 Ω values (1/10 watt). Other resistors can be 10% (1/10 watt). Capacitors should be 10% ceramic chips. The circuit in Figure 4 requires 1% resistors for the two 105 Ω values (1/10 watt). Other resistors, capacitors, and inductors can be 10% values. Coilcraft 0603CS or similar inductors are recommended.

Excellent layout, grounding, and decoupling techniques must be utilized in order to achieve the desired performance from the circuits discussed in this note. As a minimum, a 4-layer PCB should be used with one ground plane layer, one power plane layer, and two signal layers.

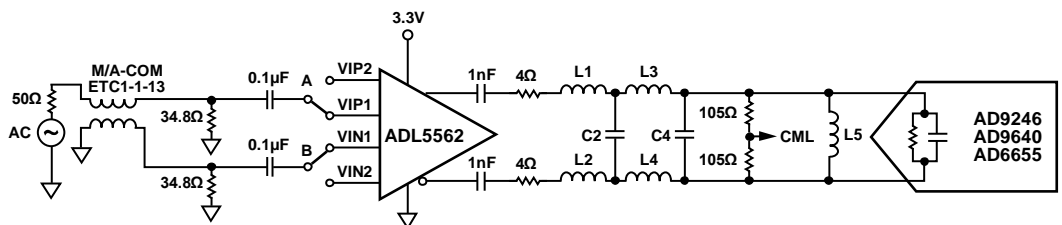


Figure 4. Narrow-Band IF Sampling Solution for Unbuffered Switched Capacitor ADC Inputs (Simplified Schematic: Decoupling and All Connections Not Shown)

Table 2. Interstage Filter Recommendations for Various IF Sampling Frequencies

Center Frequency	1 dB Bandwidth	L1	C2	L3	C4	L5
96 MHz	28 MHz	3.3 nH	47 pF	27 nH	75 pF	100 nH
140 MHz	33 MHz	3.3 nH	47 pF	27 nH	33 pF	120 nH
170 MHz	32 MHz	3.3 nH	56 pF	27 nH	22 pF	110 nH
211 MHz	30 MHz	3.3 nH	47 pF	27 nH	18 pF	56 nH

All IC power pins must be decoupled to the ground plane with low inductance multilayer ceramic capacitors (MLCC) of 0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$  (this is not shown in the diagrams for simplicity). Follow the recommendations on the individual data sheets.

The product evaluation boards should be consulted for recommended layout and critical component placement. These can be accessed through the main product pages for the devices.

Even though the [ADL5562](#) and the [AD9445](#) (or other ADC) may be powered from different supplies, sequencing is not an issue because the input signal to the ADC is ac-coupled.

The individual data sheet for the ADC should be consulted regarding the proper sequencing of the AVDD and the DVDD power supplies (if separate supplies are used).

The [ADL5562](#) low distortion differential amplifier can be replaced by the high IP3, low noise figure [AD8375](#) variable gain amplifier (VGA). The [AD8375](#) is a digitally controlled, variable gain, wide bandwidth amplifier that provides precise gain control across a broad 24 dB gain range with 1 dB resolution. The [AD8376](#) is a dual version of the [AD8375](#). (See [CN-0002](#)).

Another alternative differential amplifier is the [AD8352](#) (See [CN-0046](#)).

## LEARN MORE

[CN-0002](#) Circuit Note, *Using the AD8376 VGA to Drive Wide Bandwidth ADCs for High IF AC-Coupled Applications*. Analog Devices.

[CN-0046](#) Circuit Note, *Using the AD8352 as an Ultralow Distortion Differential RF/IF Front End for High Speed ADCs*. Analog Devices.

Kester, Walt. 2006. *High Speed System Applications, Chapter 2* (Optimizing Data Converter Interfaces). Analog Devices.

[MT-031](#) Tutorial, *Grounding Data Converters and Solving the Mystery of "AGND" and "DGND."* Analog Devices.

[MT-073](#) Tutorial, *High Speed Variable Gain Amplifiers (VGAs)*. Analog Devices.

[MT-075](#) Tutorial, *Differential Drivers for High Speed ADCs Overview*. Analog Devices.

[MT-101](#) Tutorial, *Decoupling Techniques*, Analog Devices.

Newman, Eric and Rob Reeder. [AN-827](#) Application Note, *A Resonant Approach to Interfacing Amplifiers to Switched-Capacitor ADCs*. Analog Devices.

Reeder, Rob. [AN-742](#) Application Note, *Frequency Domain Response of Switched Capacitor ADCs*. Analog Devices.

## Data Sheets and Evaluation Boards

[AD6655](#) Data Sheet

[AD8352](#) Data Sheet

[AD8375](#) Data Sheet

[AD8376](#) Data Sheet

[AD9246](#) Data Sheet

[AD9445](#) Data Sheet

[AD9445](#) Evaluation Board

[AD9640](#) Data Sheet

[High Speed ADC Evaluation Kits and Evaluation Boards](#)

## REVISION HISTORY

4/13—Rev. 0 to Rev. A

Changed Document Title from CN-0110 to AN-1204..... Universal

9/09—Revision 0: Initial Version